

Search Notes

Application/Control No.

10/001,895

Examiner

X. L. Bautista

Applicant(s)/Patent under
Reexamination

HULL ET AL.

Art Unit

2179

SEARCHED

Class	Subclass	Date	Examiner
715	700,716	4/23/2007	XB
	717,719		
	727,764		
	835,838		
	839,855		
715	500.1		
	501.1		
	513,517		
	526		
705	55		
358	1.1,1.15		
	1.18		
	530		
	540		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
715	716,719	4/27/2007	XB
715	835,838		
358	540		
715/500.1,501.1,513, 517,526			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	4/23/2007	XB
Databases Searched:US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB		
IEEE Search		
Google Search		